

Search Notes

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Soon D. Hyun

Applicant(s)/Patent under
Reexamination

WONG ET AL.

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

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interference search-see printout		3/7/2007	HY

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
370/229,230,232,235,389,392,401,42 2,423,445,446,468;709/220-226;text search only-see search history printout	3/7/2007	HY